

General Description

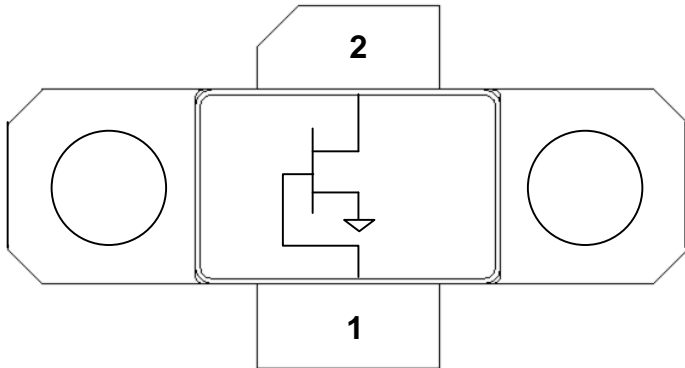
The QPD1008L is a 125 W (P_{3dB}) wideband unmatched discrete GaN on SiC HEMT which operates from DC to 3.2 GHz with a 50V supply rail. The device is in an industry standard air cavity package and is ideally suited for military and civilian radar, land mobile and military radio communications, avionics, and test instrumentation. The device can support pulsed, CW, and linear operation.

Lead-free and ROHS compliant

Evaluation boards are available upon request.



Functional Block Diagram



Product Features

- Frequency: DC to 3.2 GHz
 - Output Power (P_{3dB})¹: 162 W
 - Linear Gain¹: 17.5 dB
 - Typical $DEFF_{3dB}$ ¹: 74%
 - Operating Voltage: 50 V
 - Low thermal resistance package
 - CW and Pulse capable
- Note: 1 @ 2 GHz

Applications

- Military radar
- Civilian radar
- Land mobile and military radio communications
- Test instrumentation
- Wideband or narrowband amplifiers
- Jammers
- Avionics

Part No.	Description
QPD1008L	DC–3.2 GHz RF Transistor
QPD1008LPCB4B01	0.96 – 1.215 GHz EVB
QPD1008LEVB2	1.1 – 1.5 GHz EVB
QPD1008LEVB3	2.7 – 3.1 GHz EVB

Absolute Maximum Ratings

Parameter	Rating
Drain to Gate Voltage (V_{DG})	145 V
Gate Voltage Range (V_G)	-7 to +2 V
RF Input Power, CW, 50 Ω , T = 25 °C	40 dBm
Power Dissipation, P_{DISS}	See Pages 4-5
Storage Temperature	-65 to 150°C

Exceeding any one or a combination of the Absolute Maximum Rating conditions may cause permanent damage to the device. Extended application of Absolute Maximum Rating conditions to the device may reduce device reliability.

Recommended Operating Conditions

Parameter	Min	Typ	Max	Unit
Drain Voltage (V_D)	+12	+48	+55	V
Carrier Gate Voltage (V_G)		-2.8		V
Carrier Quiescent Current (I_{DQ1})		260		mA
Operating Temperature Range	-40	+25	+85	°C

Electrical specifications are measured at specified test conditions. Specifications are not guaranteed over all recommended operating conditions.

Note:

- To be adjusted to desired I_{DQ}

Electrical Characterization

Symbol	Parameter	Min	Typical	Max	Units
Gate Leakage	$V_D = +10$ V, $V_G = -3.8$ V	-23.1			mA

Pulsed Characterization – Load-Pull Performance – Power Tuned¹

Parameters	Typical Values			Unit
	1	2	3	
Frequency, F	1	2	3	GHz
Linear Gain, G_{LIN}	22.5	17.5	14.1	dB
Output Power at 3dB compression point, P_{3dB}	52.0	52.1	51.9	dBm
Drain Efficiency at 3dB compression point, $DEFF_{3dB}$	63.4	62.1	59.2	%
Gain at 3dB compression point	19.5	14.4	11.1	dB

Notes:

1. Test conditions unless otherwise noted: $V_D = +50\text{ V}$, $I_D = 260\text{ mA}$, $Temp = +25\text{ }^\circ\text{C}$

Pulsed Characterization – Load-Pull Performance – Efficiency Tuned¹

Parameters	Typical Values			Unit
	1	2	3	
Frequency	1	2	3	GHz
Linear Gain, G_{LIN}	23.5	18.6	15.2	dB
Output Power at 3dB compression point, P_{3dB}	48.2	50.2	51.0	dBm
Drain Efficiency at 3dB compression point, $DEFF_{3dB}$	76.2	74.6	69.7	%
Gain at 3dB compression point, G_{3dB}	20.5	15.6	12.2	dB

Notes:

1. Test conditions unless otherwise noted: $V_D = +50\text{ V}$, $I_{DQ} = 260\text{ mA}$, $Temp = +25\text{ }^\circ\text{C}$

RF Characterization – EVB1 Performance at 1.09 GHz¹

Parameter	Min	Typ	Max	Units
Linear Gain, G_{LIN}	–	20	–	dB
Output Power at 3dB compression point, P_{3dB}	–	51.2	–	dBm
Drain Efficiency at 3dB compression point, $DEFF_{3dB}$	–	73.5	–	%
Gain at 3dB compression point, G_{3dB}	–	17	–	dB

Notes:

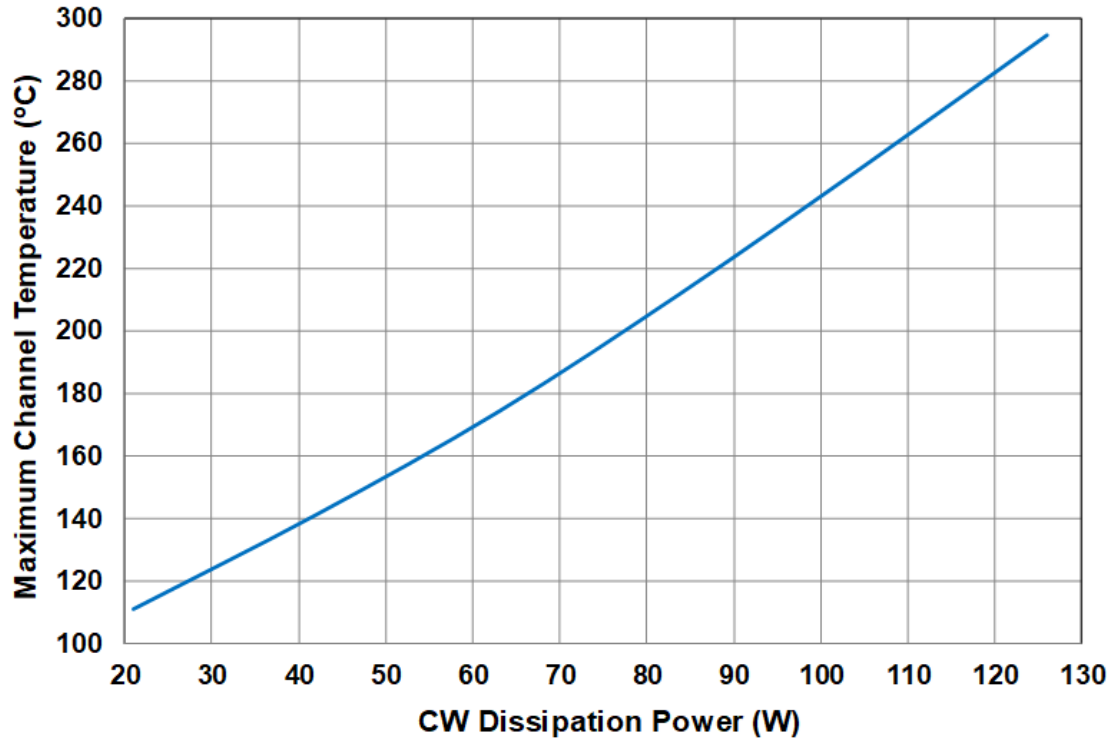
1. $V_D = +50\text{ V}$, $I_{DQ} = 260\text{ mA}$, $Temp = +25\text{ }^\circ\text{C}$, Pulse Width = 128 μs , Duty Cycle = 10%

RF Characterization – Mismatch Ruggedness at 1.09 GHz

Symbol	Parameter	dB Compression	Typical
VSWR	Impedance Mismatch Ruggedness	3	10:1

Test conditions unless otherwise noted: $T_A = 25\text{ }^\circ\text{C}$, $V_D = 50\text{ V}$, $I_{DQ} = 260\text{ mA}$

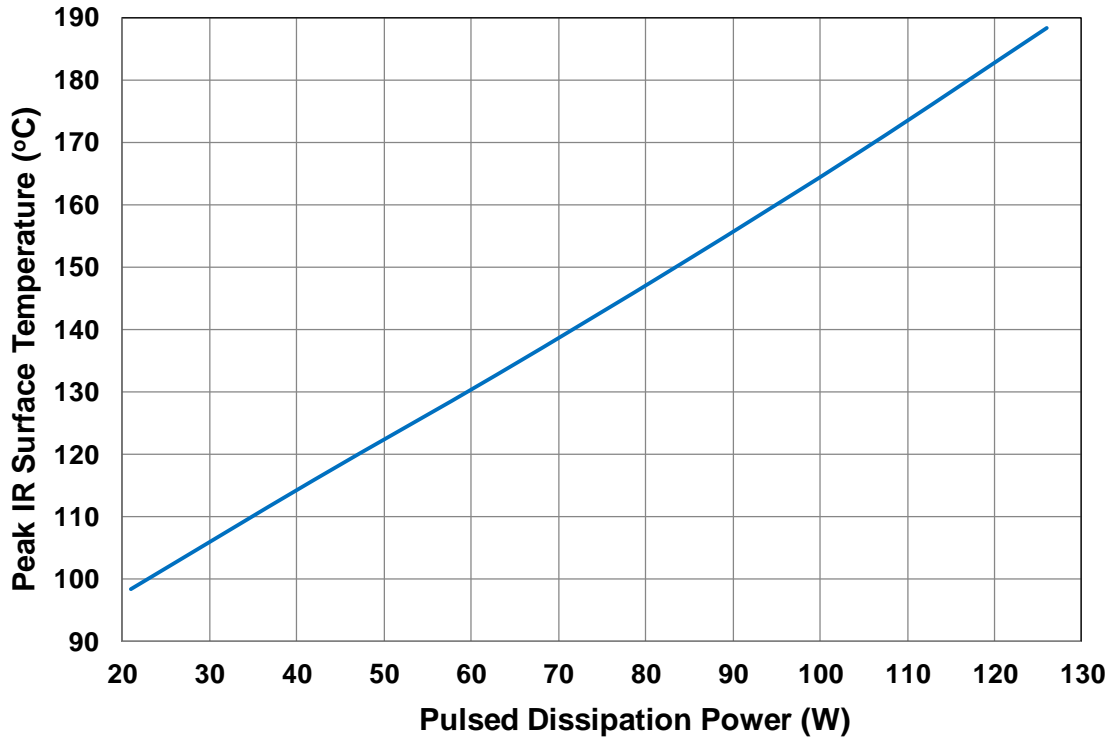
Driving input power is determined at pulsed 3dB compression under matched condition at EVB output connector.

Thermal and Reliability Information - CW ⁽¹⁾
Peak IR Surface Temperature vs. CW Dissipation Power


Parameter	Test Conditions	Value	Units
Thermal Resistance, Peak IR Surface Temperature at Average Power (θ_{JC})	$P_{DISS} = 21\text{ W}$, $T_{baseplate} = 85^{\circ}\text{C}$	1.24	$^{\circ}\text{C/W}$
Channel Temperature, T_{CH}		111	$^{\circ}\text{C}$
Thermal Resistance, Peak IR Surface Temperature at Average Power (θ_{JC})	$P_{DISS} = 42\text{ W}$, $T_{baseplate} = 85^{\circ}\text{C}$	1.33	$^{\circ}\text{C/W}$
Channel Temperature, T_{CH}		141	$^{\circ}\text{C}$
Thermal Resistance, Peak IR Surface Temperature at Average Power (θ_{JC})	$P_{DISS} = 63\text{ W}$, $T_{baseplate} = 85^{\circ}\text{C}$	1.41	$^{\circ}\text{C/W}$
Channel Temperature, T_{CH}		174	$^{\circ}\text{C}$
Thermal Resistance, Peak IR Surface Temperature at Average Power (θ_{JC})	$P_{DISS} = 84\text{ W}$, $T_{baseplate} = 85^{\circ}\text{C}$	1.51	$^{\circ}\text{C/W}$
Channel Temperature, T_{CH}		212	$^{\circ}\text{C}$
Thermal Resistance, Peak IR Surface Temperature at Average Power (θ_{JC})	$P_{DISS} = 105\text{ W}$, $T_{baseplate} = 85^{\circ}\text{C}$	1.6	$^{\circ}\text{C/W}$
Channel Temperature, T_{CH}		253	$^{\circ}\text{C}$

Notes:

1. Thermal resistance measured to bottom of package.
2. Refer to the following document: [GaN Device Channel Temperature, Thermal Resistance, and Reliability Estimates](#)

Thermal and Reliability Information - Pulsed ⁽¹⁾
Peak IR Surface Temperature vs. Pulsed Dissipation Power


Parameter	Test Conditions	Value	Units
Thermal Resistance, Peak IR Surface Temperature at Average Power (θ_{JC})	$P_{DISS} = 42\text{ W}$, $T_{baseplate} = 85^\circ\text{C}$ Pulse Width = 128 μS	0.74	$^\circ\text{C/W}$
		Channel Temperature, T_{CH}	116
Thermal Resistance, Peak IR Surface Temperature at Average Power (θ_{JC})	$P_{DISS} = 63\text{ W}$, $T_{baseplate} = 85^\circ\text{C}$ Pulse Width = 128 μS	0.76	$^\circ\text{C/W}$
		Channel Temperature, T_{CH}	133
Thermal Resistance, Peak IR Surface Temperature at Average Power (θ_{JC})	$P_{DISS} = 84\text{ W}$, $T_{baseplate} = 85^\circ\text{C}$ Pulse Width = 128 μS	0.77	$^\circ\text{C/W}$
		Channel Temperature, T_{CH}	150
Thermal Resistance, Peak IR Surface Temperature at Average Power (θ_{JC})	$P_{DISS} = 105\text{ W}$, $T_{baseplate} = 85^\circ\text{C}$ Pulse Width = 128 μS	0.80	$^\circ\text{C/W}$
		Channel Temperature, T_{CH}	169
Thermal Resistance, Peak IR Surface Temperature at Average Power (θ_{JC})	$P_{DISS} = 126\text{ W}$, $T_{baseplate} = 85^\circ\text{C}$ Pulse Width = 128 μS	0.82	$^\circ\text{C/W}$
		Channel Temperature, T_{CH}	188

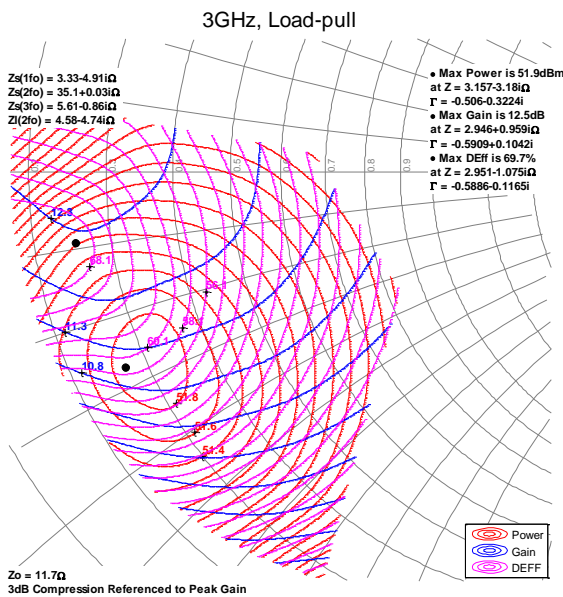
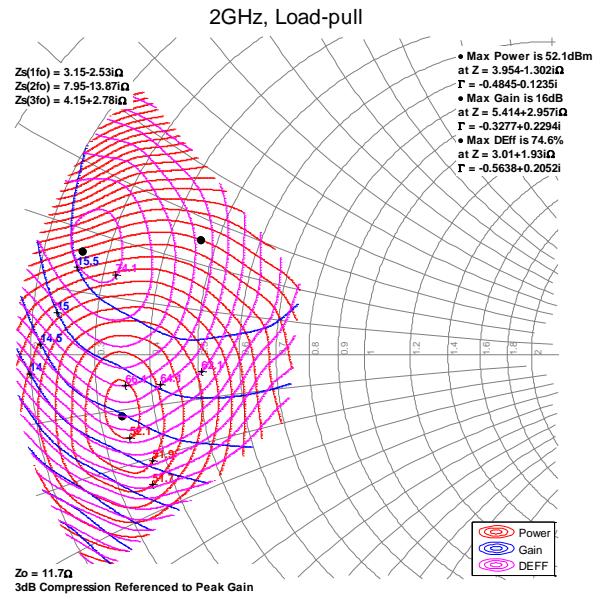
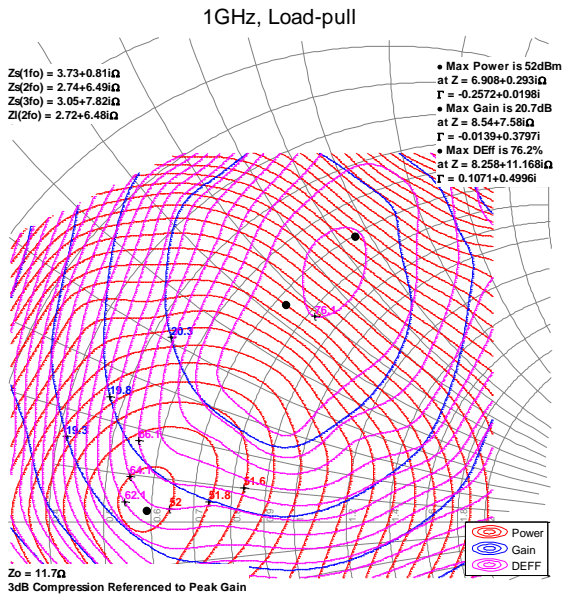
Notes:

1. Thermal resistance measured to bottom of package.
2. Refer to the following document: [GaN Device Channel Temperature, Thermal Resistance, and Reliability Estimates](#)

Load-Pull Smith Charts^{1, 2}

Notes:

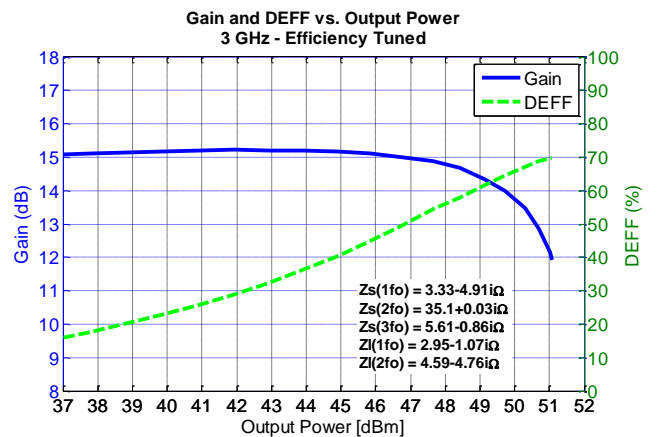
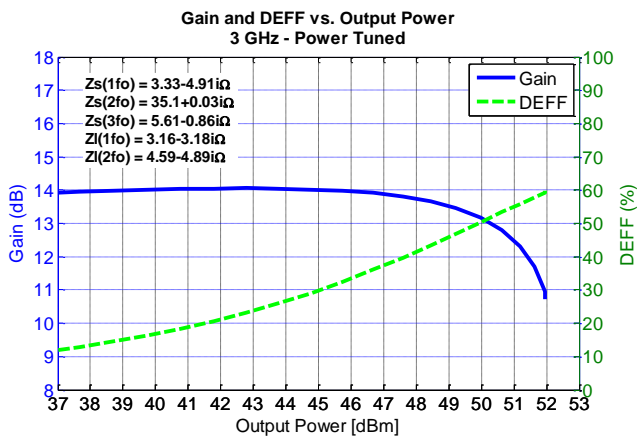
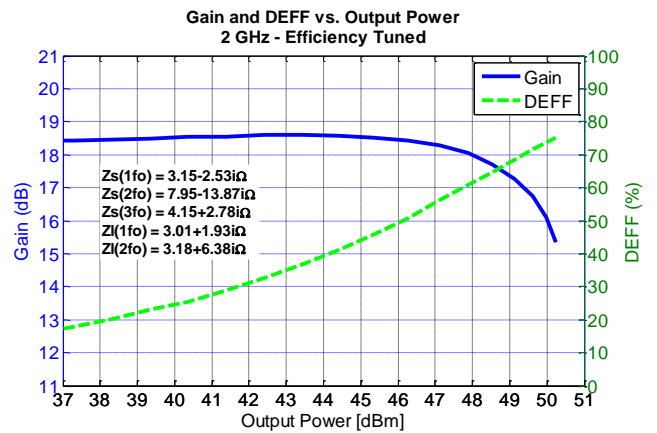
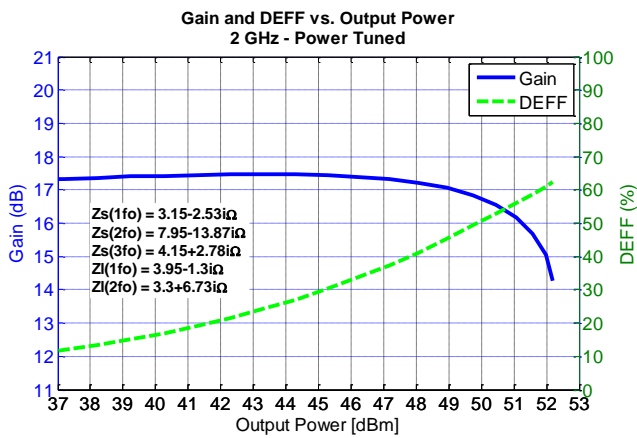
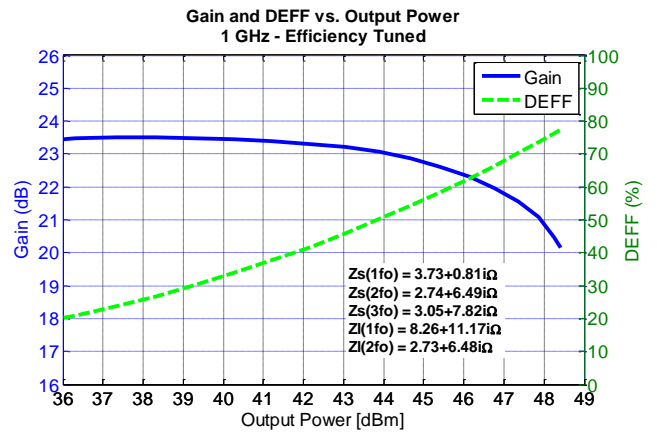
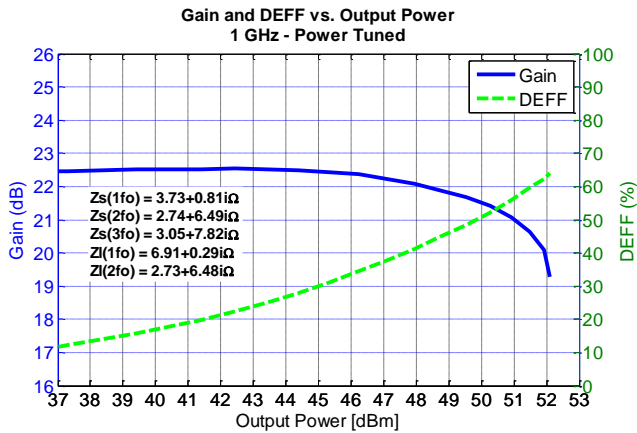
1. 50 V, 260 mA, Pulsed signal with 128 uS pulse width and 10 % duty cycle.
2. See page 13 for load-pull and source-pull reference planes. 11.7-Ω load-pull TRL fixtures are built with 32-mil RO4360G2 material.



Typical Performance – Load-Pull Drive-up

Notes:

1. Pulsed signal with 128 uS pulse width and 10 % duty cycle, $V_d = 50\text{ V}$, $I_{DQ} = 260\text{ mA}$.
2. See page 13 for load-pull and source-pull reference planes where the performance was measured.

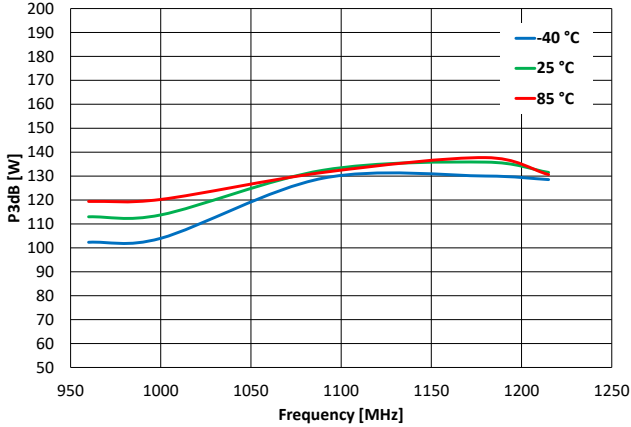


Power Driveup Performance Over Temperatures Of 0.96 – 1.215 GHz EVB¹

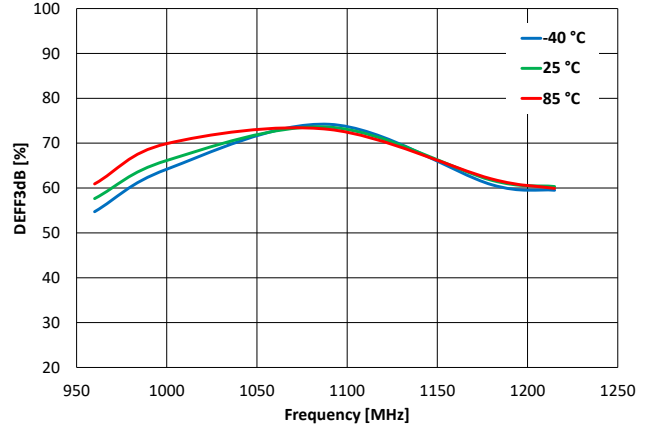
Notes:

1. Pulsed signal with 128 uS pulse width and 10 % duty cycle, $V_d = 50\text{ V}$, $I_{DQ} = 260\text{ mA}$.

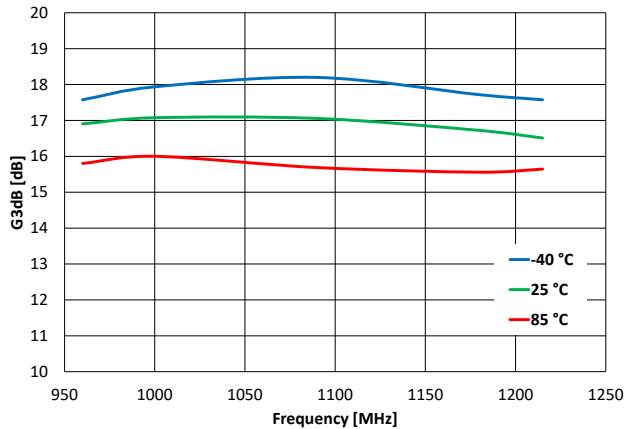
P3dB Over Temperatures



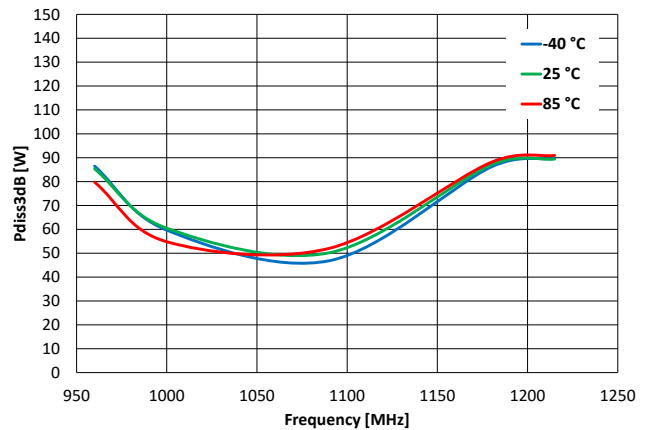
DEFF3dB Over Temperatures



G3dB Over Temperatures



Pdiss3dB Over Temperatures

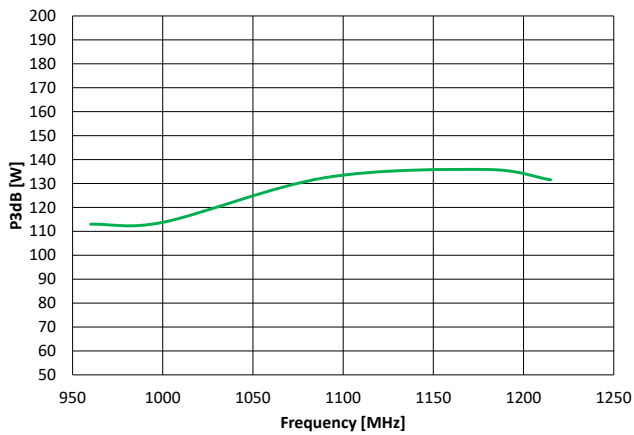


Typical Performance – 0.96 – 1.215 GHz EVB at 25 °C ¹

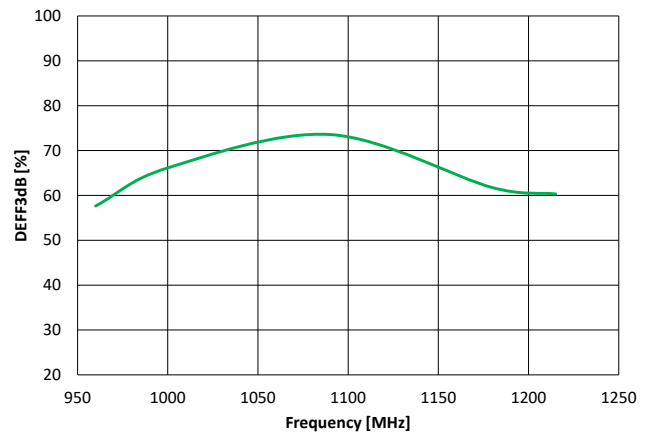
Notes:

1. Pulsed signal with 128 uS pulse width and 10 % duty cycle, $V_d = 50\text{ V}$, $I_{DQ} = 260\text{ mA}$

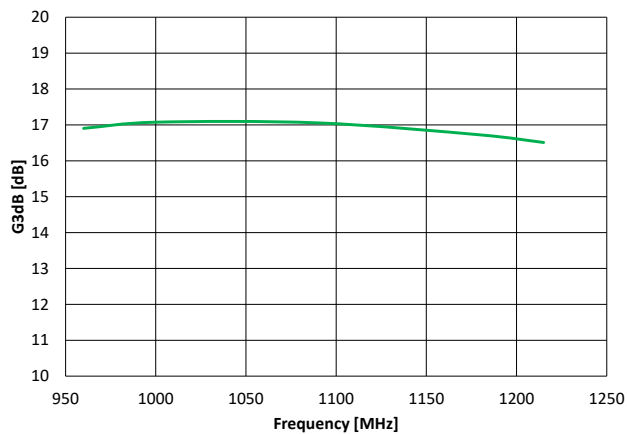
P3dB At 25 °C



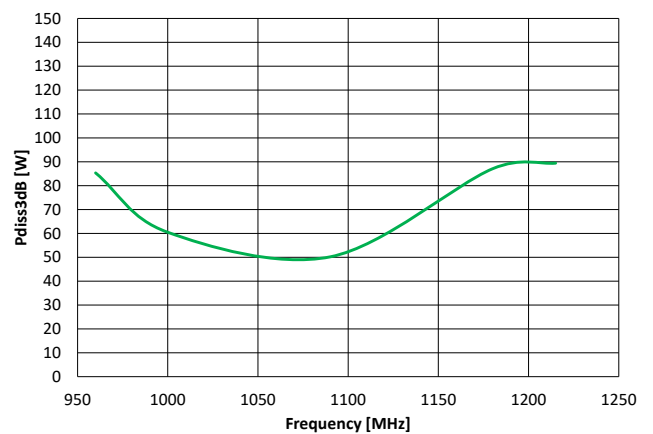
DEFF3dB At 25 °C



G3dB At 25 °C



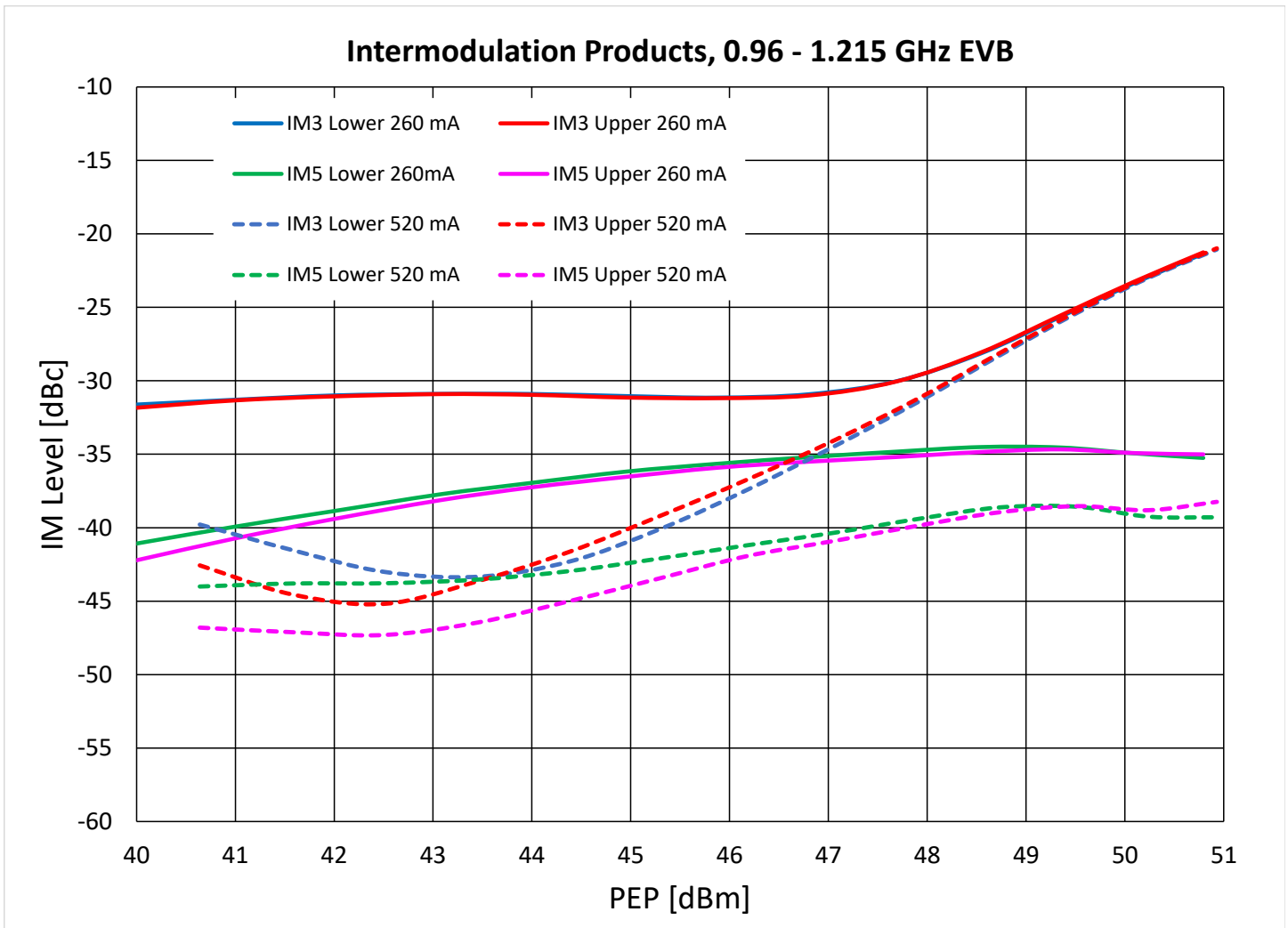
Pdiss3dB At 25 °C



Typical 2-Tone Performance – 0.96 – 1.215 GHz EVB at 25 °C ¹

Notes:

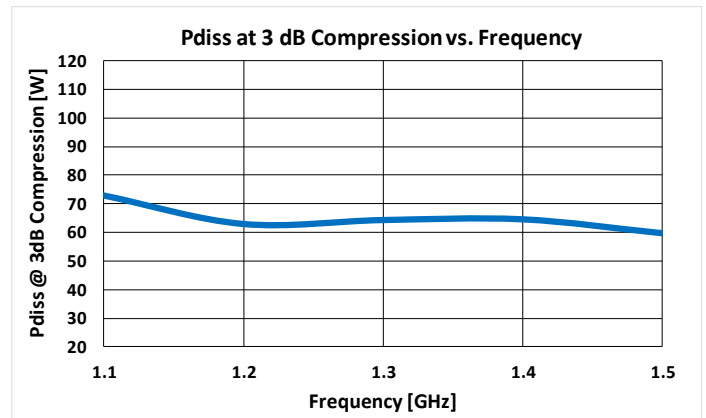
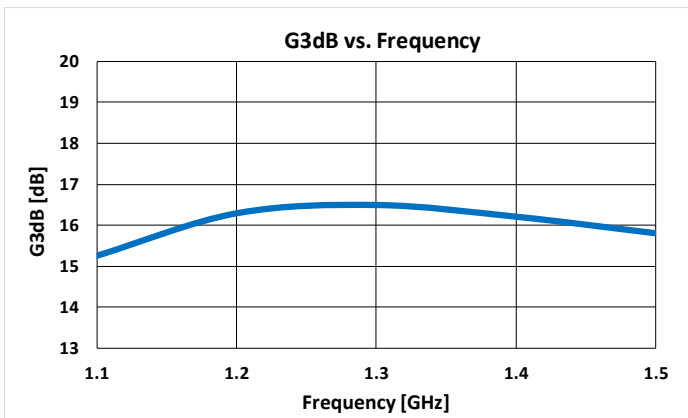
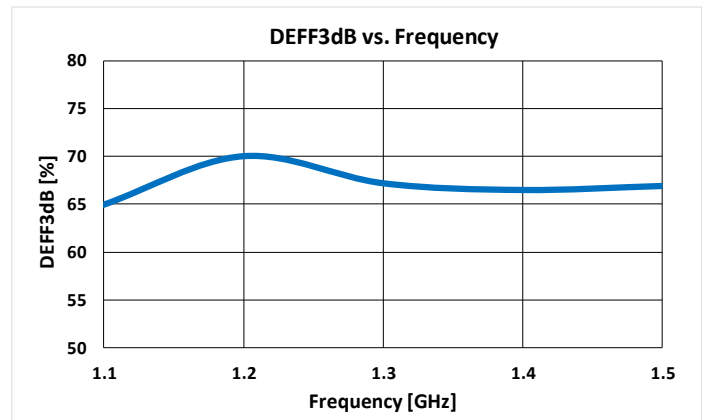
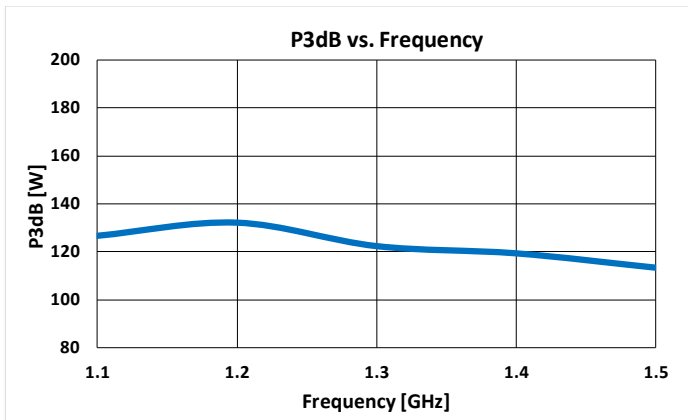
- Center Frequency = 1.095 GHz, Tone Spacing = 10 MHz, I_{BQ} = 260 mA and 520 mA.



Typical Performance – 1.1 – 1.5 GHz EVB at 25 °C ¹

Notes:

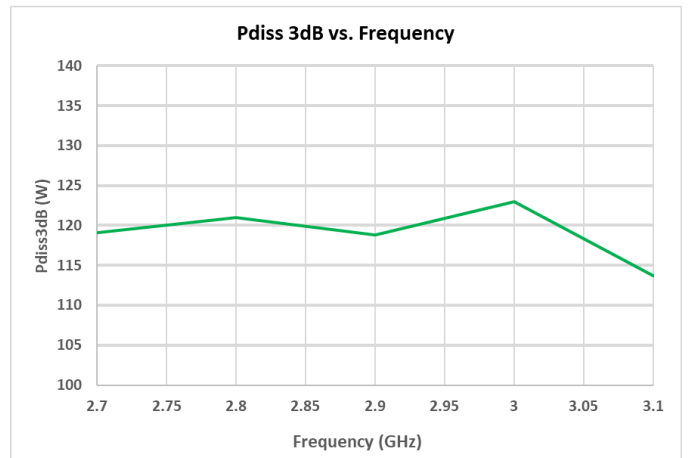
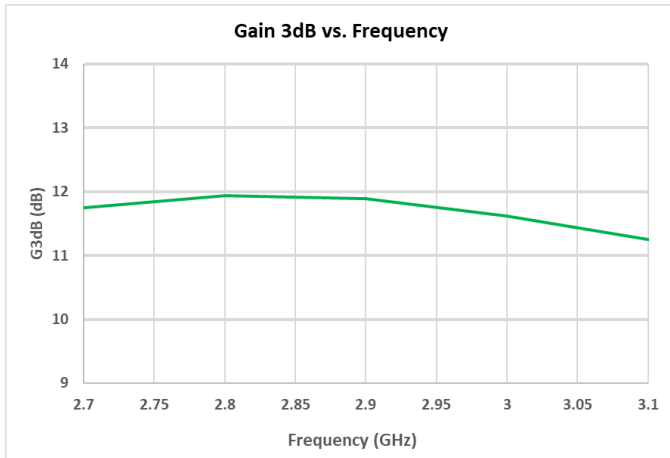
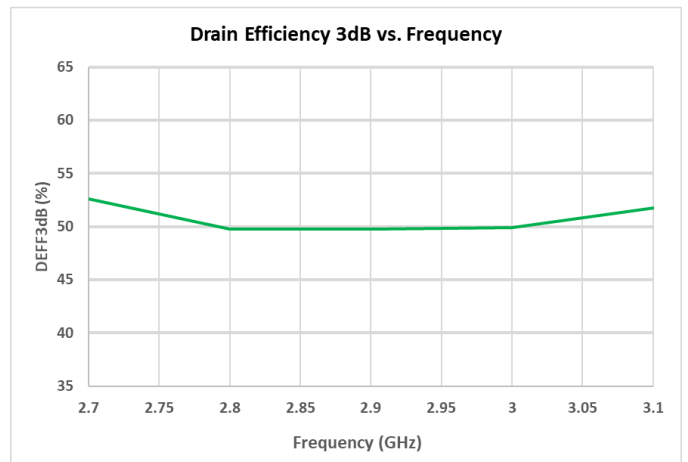
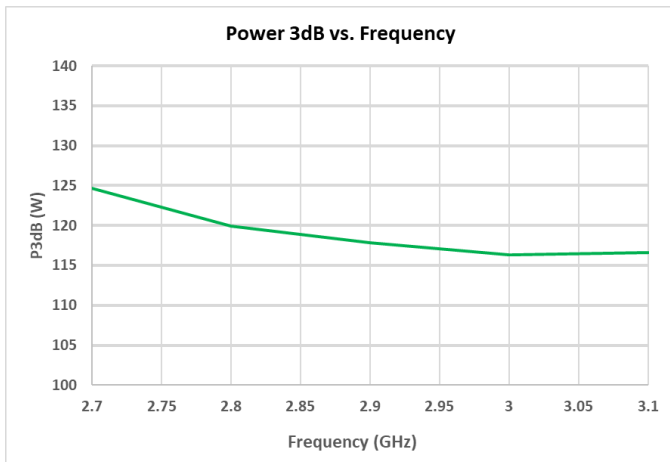
1. Pulsed signal with 128 uS pulse width and 10 % duty cycle, $V_d = 50\text{ V}$, $I_{b0} = 260\text{ mA}$.



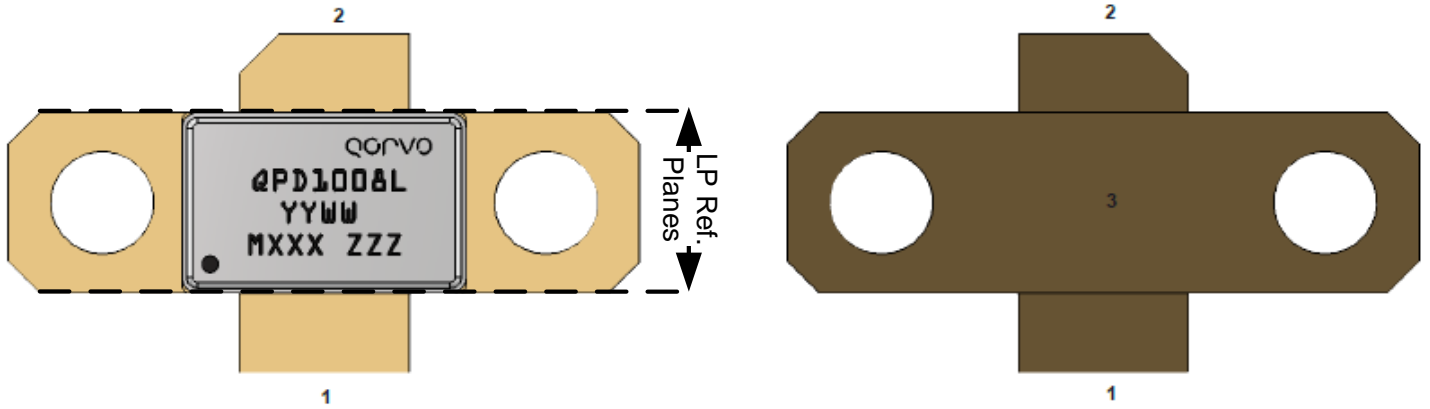
Typical Performance – 2.7 – 3.1 GHz EVB at 25 °C ¹

Notes:

1. Pulsed signal with 128 uS pulse width and 10 % duty cycle, $V_d = 50\text{ V}$, $I_{DQ} = 260\text{ mA}$.



Pin Layout¹



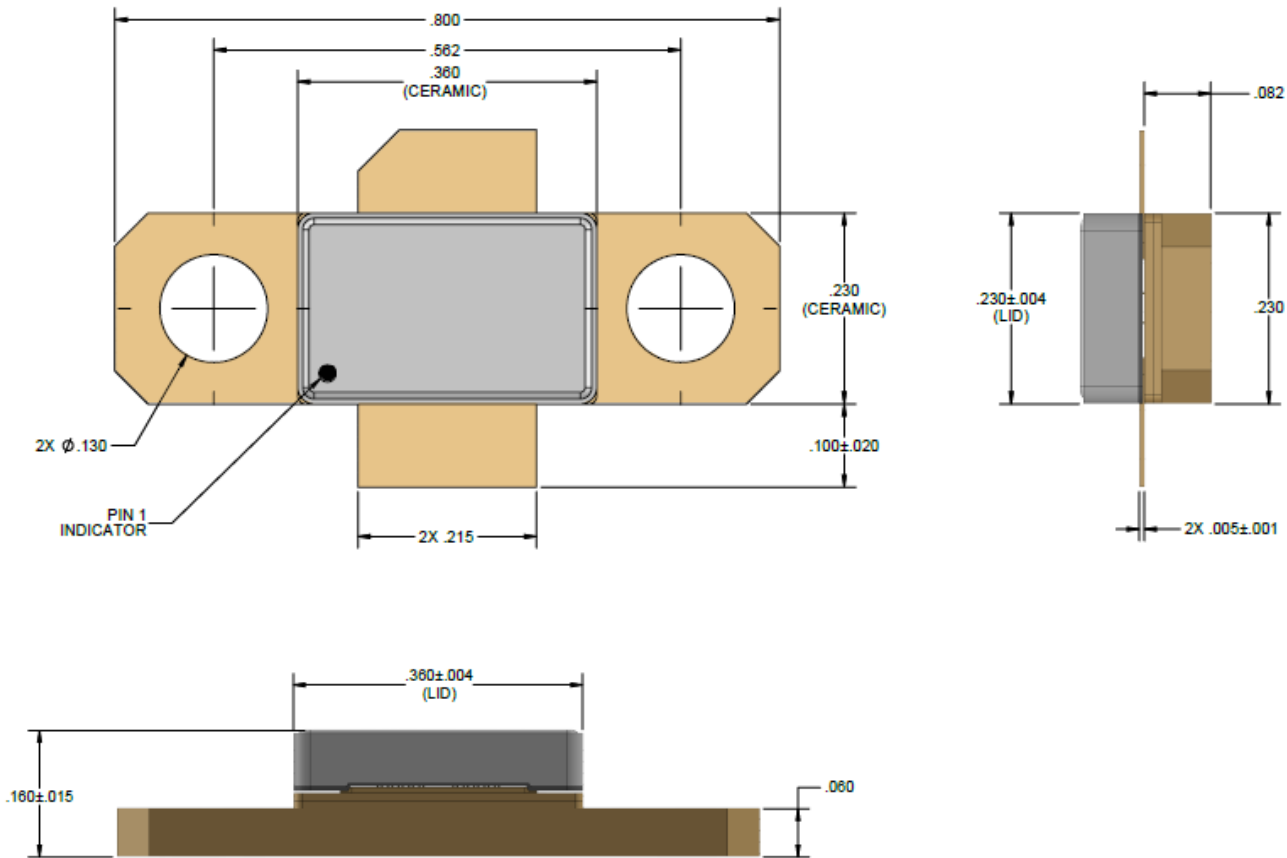
Notes:

- The QPD1008L will be marked with the “QPD1008L” designator and a lot code marked below the part designator. The “YY” represents the last two digits of the calendar year the part was manufactured, the “WW” is the work week of the assembly lot start, the “MXXX” is the production lot number, and the “ZZZ” is an auto-generated serial number.

Pin Description

Pin	Symbol	Description
1	VG / RF IN	Gate voltage / RF Input
2	VD / RF OUT	Drain voltage / RF Output
3	Flange	Source to be connected to ground

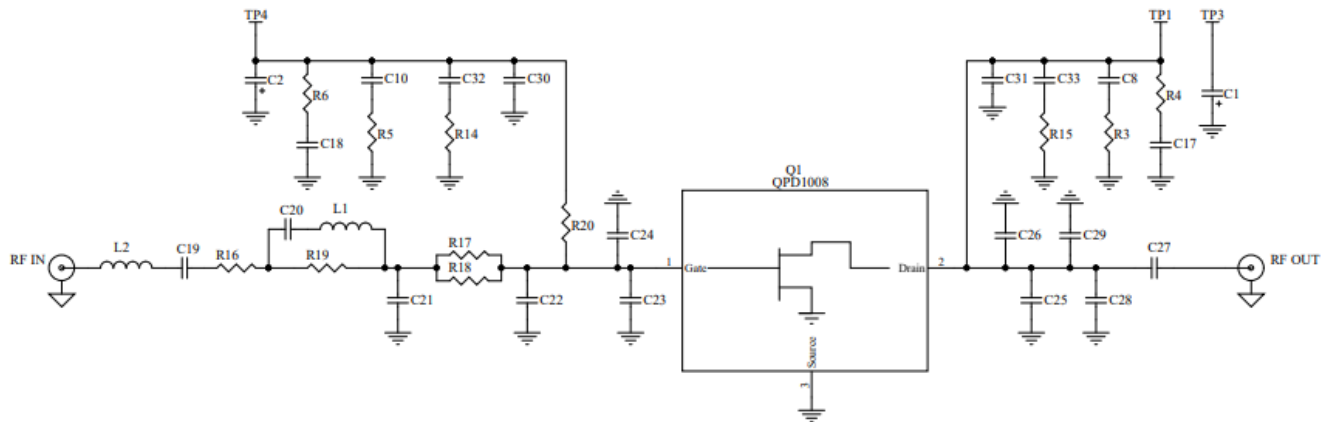
Mechanical Drawing¹



Note 1:

1. All dimensions are in inches. Angles are in degrees.
2. Dimension tolerance is ± 0.005 inches, unless otherwise noted.
3. Material:
Package Base: Ceramic / Metal
Package Lid: Ceramic
4. Package exposed metallization is gold plated.
5. Part is epoxy sealed.
6. Part meets industry NI360 footprint.
7. Body dimensions do not include epoxy runout which can be up to 0.020 inches per side.

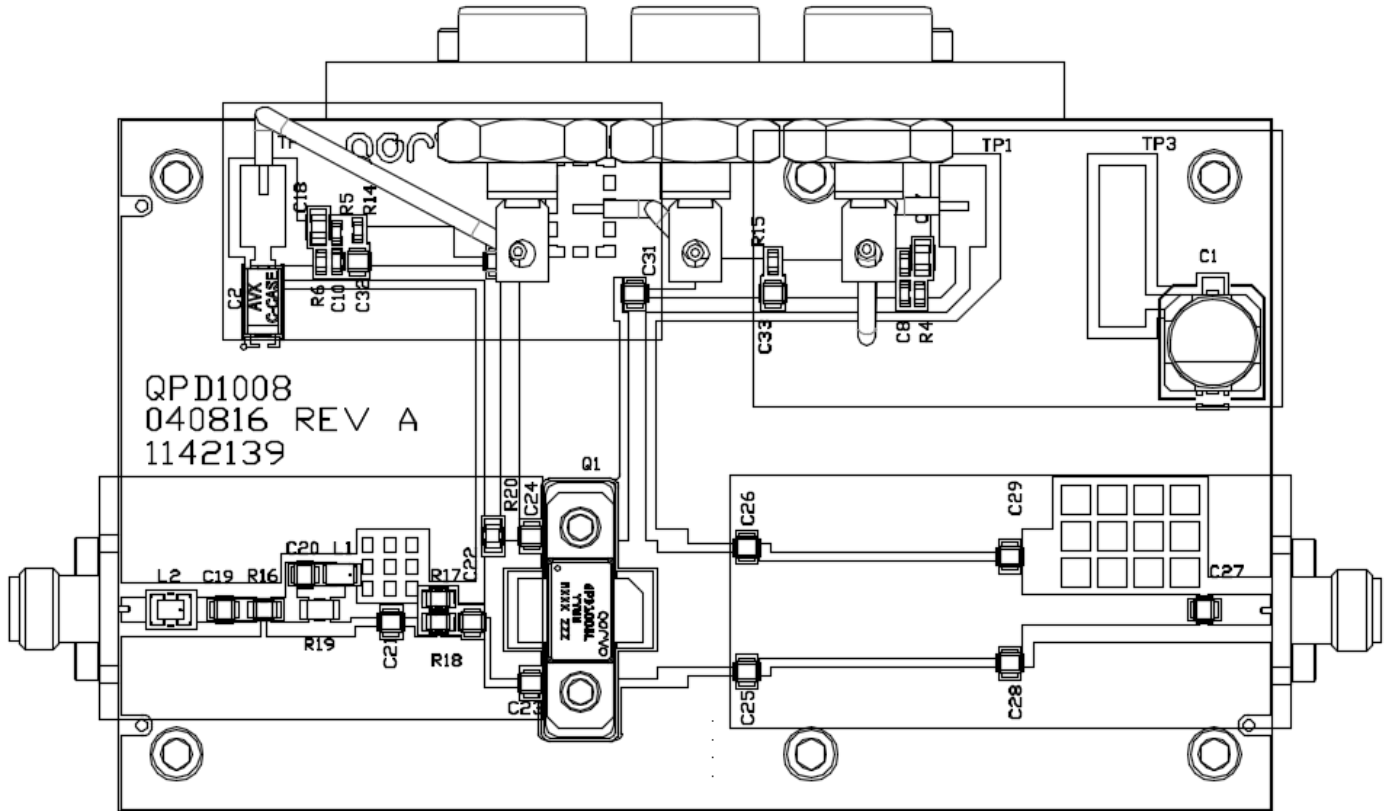
0.96 – 1.215 GHz Application Circuit - Schematic



Bias-up Procedure	Bias-down Procedure
1. Set V_G to -4 V.	1. Turn off RF signal.
2. Set I_D current limit to 300 mA.	2. Turn off V_D
3. Apply 50 V V_D .	3. Wait 2 seconds to allow drain capacitor to discharge
4. Slowly adjust V_G until I_D is set to 260 mA.	4. Turn off V_G
5. Set I_D current limit to 0.6 A (Pulsed operation)	
6. Apply RF.	

0.96 – 1.215 GHz Application Circuit - Layout

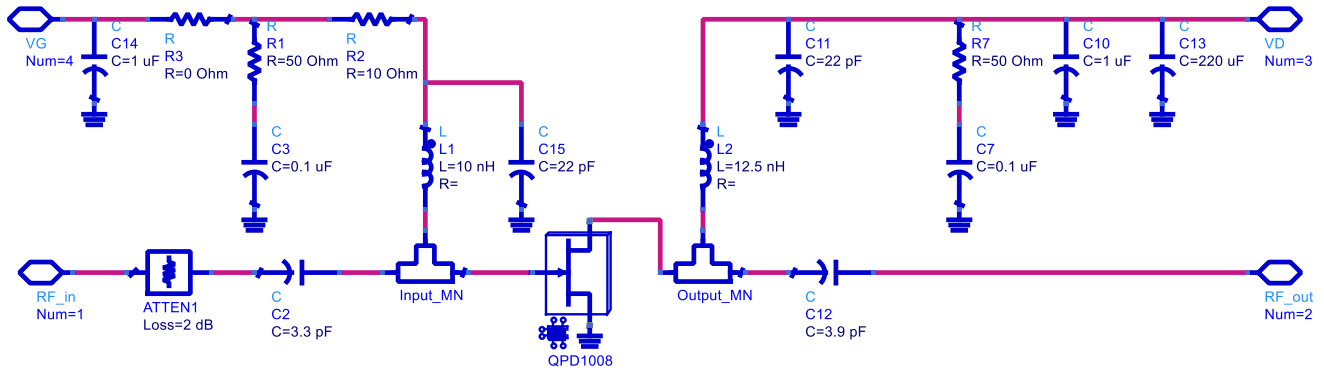
Board material is RO4360G2 0.032" thickness with 1oz copper cladding.
EVB dimension is 2.36" x 3.94".



0.96 – 1.215 GHz Application Circuit - Bill Of material

Ref Des	Value	Description	Manufacturer	Part Number
C8, 10	1 nF	X7R 100V 5% 0603 Capacitor	AVX	06031C102JAT2A
C17 - 18	100 nF	X7R 100V 5% 0805 Capacitor	AVX	08051C104JAT2A
C28 - 29	2 pF	RF NPO 250VDC ± 0.1 pF Capacitor	AVX	800A2R0BT250XT
C23 – 24	2.4 pF	RF NPO 250VDC ± 0.1 pF Capacitor	AVX	800A2R4BT250XT
C20	3.0 pF	RF NPO 250VDC ± 0.1 pF Capacitor	AVX	800A3R0BT250X
C21	4.7pF	RF NPO 250VDC ± 0.1 pF Capacitor	AVX	800A4R7BT250XT
C25, 26	6.2 pF	RF NPO 250VDC ± 0.1 pF Capacitor	Passive Plus	0505C6R2BW301X
C22	13 pF	RF NPO 250VDC 1% Capacitor	AVX	800A100FT250X
C19, 27, 30, 31	56 pF	RF NPO 250VDC 1% Capacitor	Passive Plus	0505C560FW151X
C32, 33	100 pF	RF NPO 250VDC 1% Capacitor	Passive Plus	0505C101FW151X
C1	33 uF	RF NPO 250VDC 1% Capacitor	Panasonic	63SXV33M
C2	10 uF	RF NPO 250VDC 1% Capacitor	AVX	TPSC106KR0500
J1 - 2		SMA Panel Mount 4-hole Jack	Gigalane	PSF-S00-000
L1	5.6 nH	0805 5% Inductor	Coilcraft	0805CS-050XJE
L2	4.1 nH	0805 5% Inductor	Coilcraft	1008HQ-4N1X-LB
R4, 6	1 Ohm	0603 Thick Film Resistor	ANY	
R5	3.3 Ohm	0603 Thick Film Resistor	ANY	
R14, 15	5.1 Ohm	0603 Thick Film Resistor	ANY	
R16	4.0 Ohm	0805CS High Power Thick Film Resistor		ND3-0805CS4R00J
R3	33 Ohm	0603 Thick Film Resistor	ANY	
R20	3.9 Ohm	0805 Thick Film Resistor	ANY	
R17, 18	7 Ohm	0805CS High Power Thick Film Resistor	IMS	ND3-0805CS7R00J
R19	510 Ohm	1206 Thick Film Resistor	ANY	

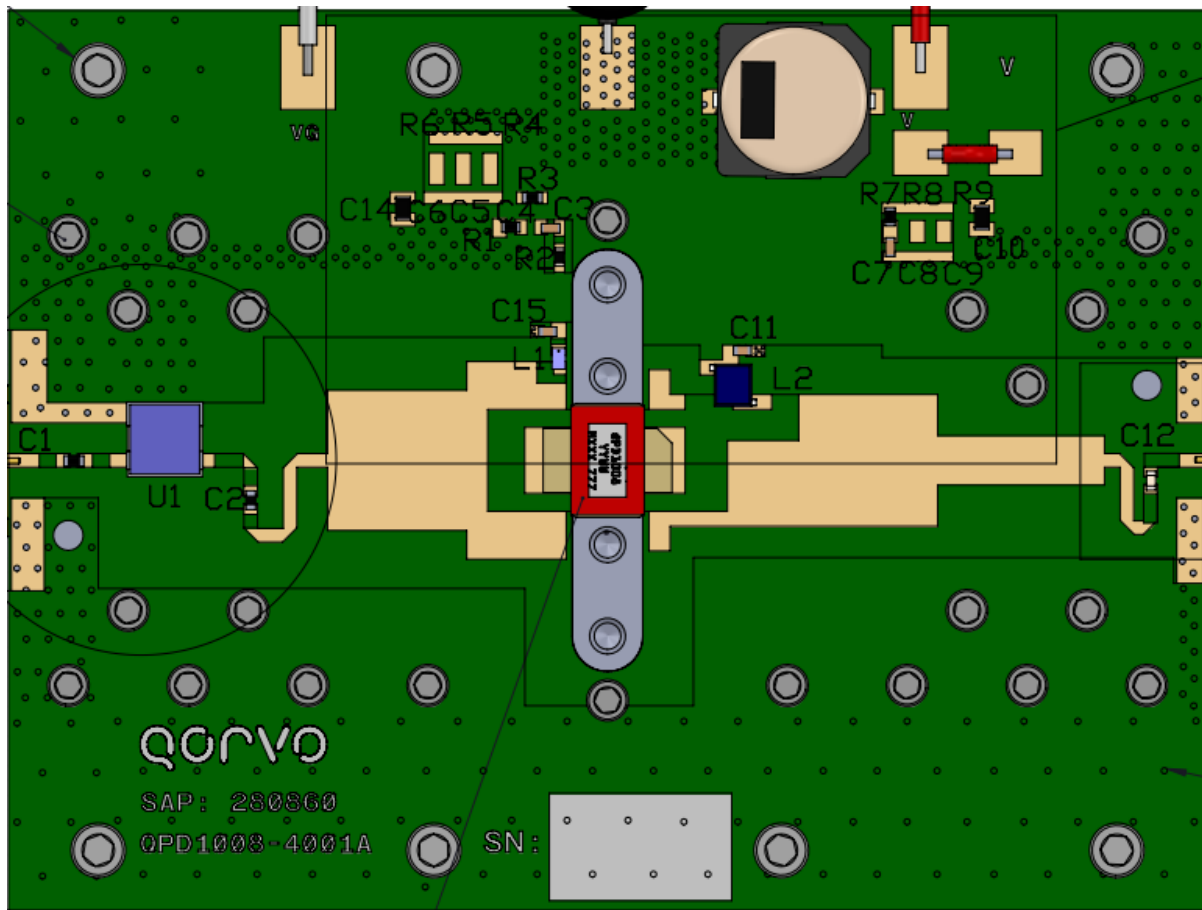
1.1 – 1.5 GHz Application Circuit - Schematic



Bias-up Procedure	Bias-down Procedure
2. Set V_G to -4 V.	3. Turn off RF signal.
4. Set I_D current limit to 300 mA.	4. Turn off V_D
5. Apply 50 V V_D .	5. Wait 2 seconds to allow drain capacitor to discharge
6. Slowly adjust V_G until I_D is set to 260 mA.	7. Turn off V_G
8. Set I_D current limit to 0.6 A (Pulsed operation)	
9. Apply RF.	

1.1 – 1.5 GHz Application Circuit - Layout

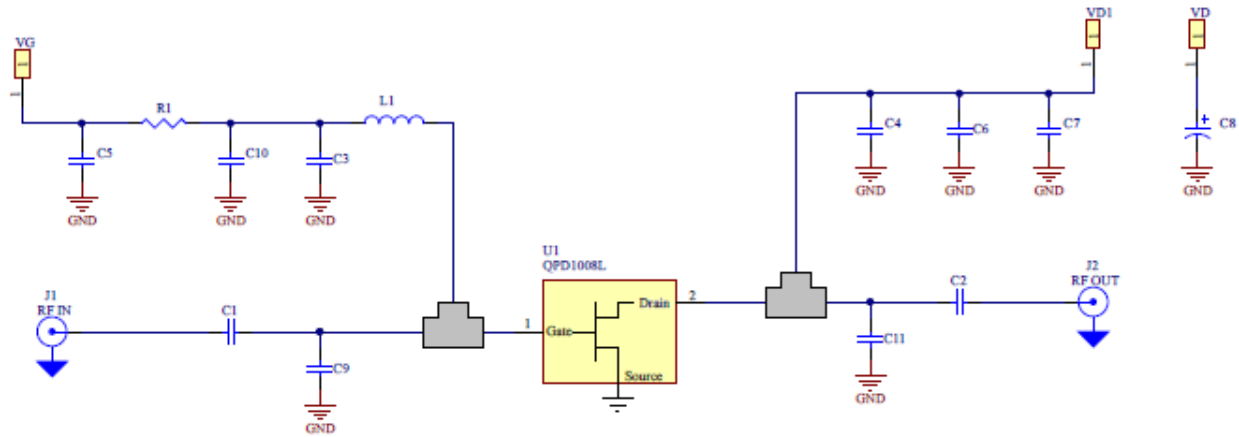
Board material is RO4360G2 0.032" thickness with 1oz copper cladding. EVB dimension is 3" x 4".



1.1 – 1.5 GHz Application Circuit - Bill Of material

Ref Des	Value	Quantity	Part Number	Manufacturer
C1	100 pF	1	0603G101J201S	Capax
C2	3.3 pF	1	600S3R3AT250XT	ATC
C12	3.9 pF	1	600S3R9AT250XT	ATC
C11, C15	22 pF	2	600S220FT250XT	ATC
C3, C7	0.1 uF	2	GRM188R72A104KA35D	Murata
C10, C14	1 uF	2	C2012X7S2A105M125AB	TDK
C13	100 uF	1	EEETG1J101UP	Panasonic
R1, R7	50 Ohm	2	CRCW060350R0FKEA-ND	Vishay
R2	10 Ohm	1	CRCW060310R0JNEA	Vishay
L1	10 nH	1	0603CS-10NXJEW	Coilcraft
L2	12.5 nH	1	A04TJLC	Coilcraft
U1	2dB Atten.	1	RFP-250250-4AA2-1	Anaren

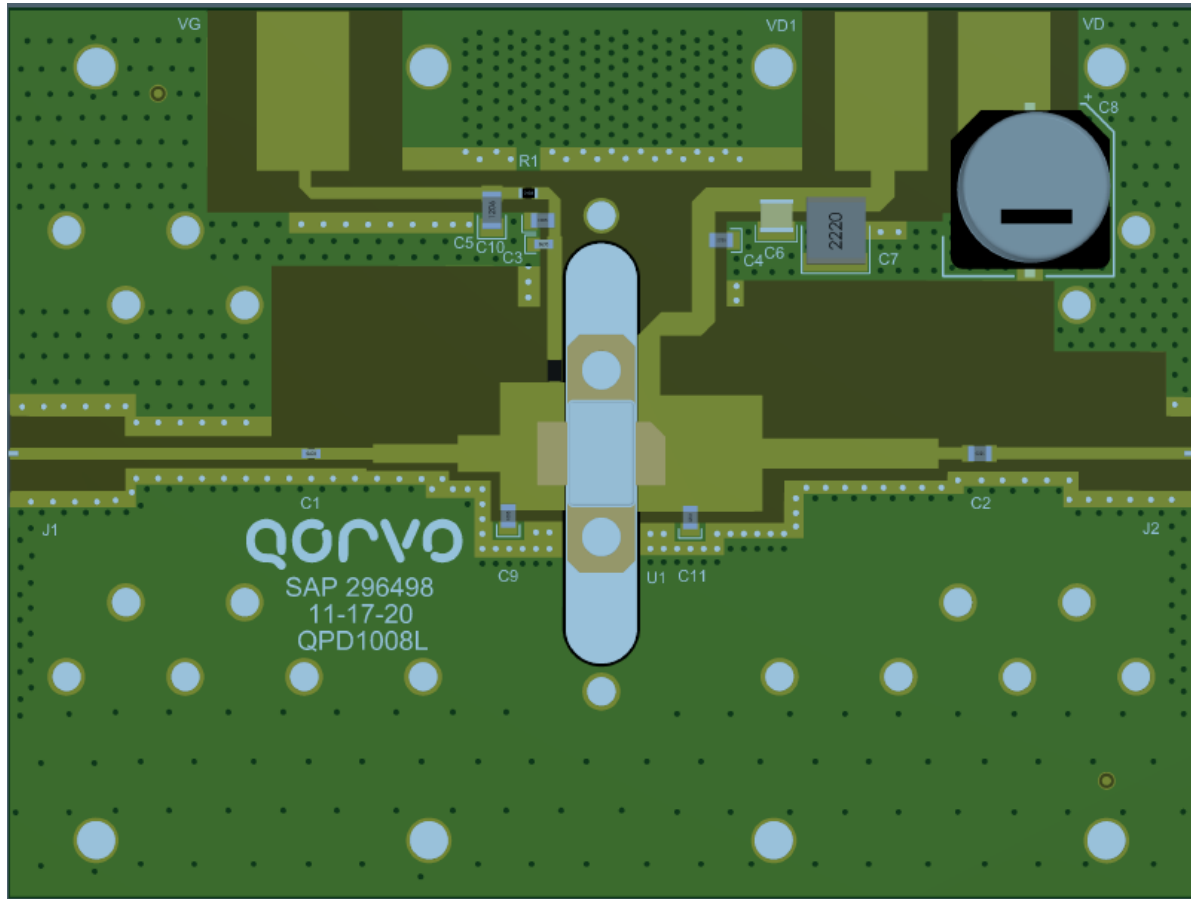
2.7 – 3.1 GHz Application Circuit - Schematic



Bias-up Procedure	Bias-down Procedure
3. Set V_G to -4 V.	5. Turn off RF signal.
6. Set I_D current limit to 300 mA.	6. Turn off V_D
7. Apply 50 V V_D .	7. Wait 2 seconds to allow drain capacitor to discharge
8. Slowly adjust V_G until I_D is set to 260 mA.	10. Turn off V_G
11. Set I_D current limit to 0.6 A (Pulsed operation)	
12. Apply RF.	

2.7 – 3.1 GHz Application Circuit - Layout

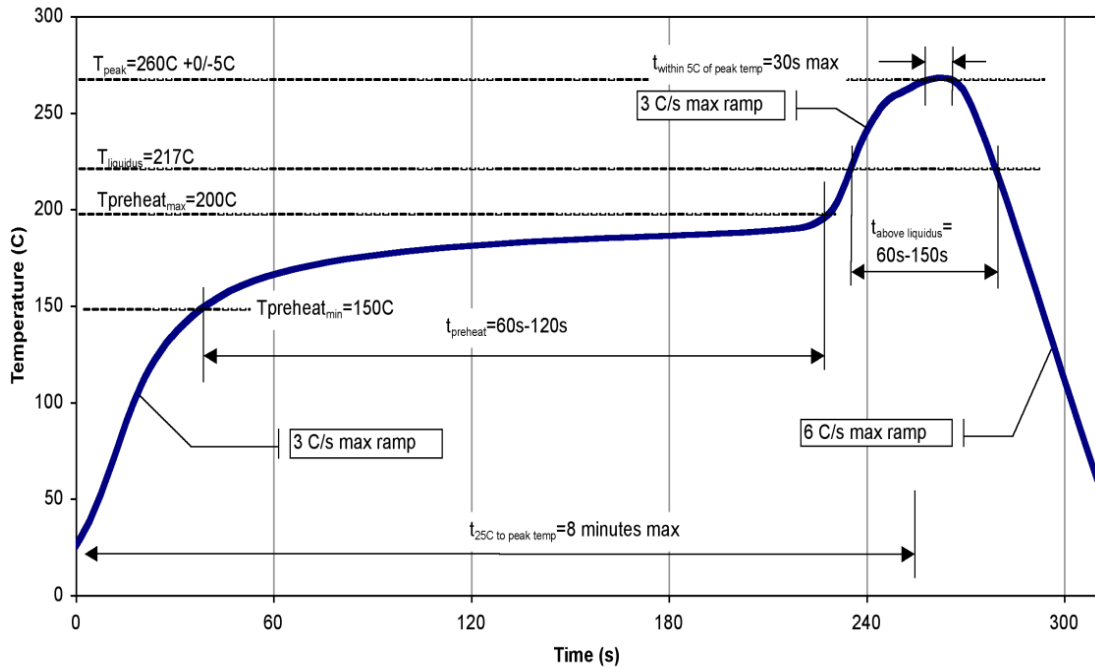
Board material is RO4350B 0.020" thickness with 1oz copper cladding. EVB dimension is 3" x 4".



2.7 – 3.1 GHz Application Circuit - Bill Of material

Ref Des	Value	Quantity	Part Number	Manufacturer
C1, C3	15 pF	2	600S150JT250XT	AVX
C2, C4	15 pF	2	600F150FT250XT	AVX
C5	10 uF	1	C1206C106K8RACTU	Kemet
C6	1000 pF	1	800B102JW50XT	AVX
C7	10 uF	1	C5750X7S2A106M230KB	TDK
C8	220 uF	1	EEVTG1J221Q	Panasonic
C9	0.7 pF	1	600F0R7AT250XT	AVX
C10	1 uF	1	C2012X7S2A105M125AB	TDK
C11	0.5 pF	1	600F0R5AT250XT	AVX
L1	10 nH	1	0603CS-6N8XJLC	Coilcraft
R1	10 Ohm	1	CRCW060310R0JNEA	Vishay
Q1	-	1	QPD1008L	Qorvo

Recommended Solder Temperature Profile



Handling Precautions

Parameter	Rating	Standard
ESD – Human Body Model (HBM)	Class 1A	ANSI/ESD/JEDEC JS-001
ESD – Charged Device Model (CDM)	Class C3	ANSI/ESD/JEDEC JS-002
MSL – Moisture Sensitivity Level	MSL3	IPC/JEDEC J-STD-020



Caution!
ESD-Sensitive Device

Solderability

Compatible with both lead-free (260°C max. reflow temp.) and tin/lead (245°C max. reflow temp.) soldering processes. Solder profiles available upon request.

Contact plating: NiAu. Au thickness is 60 microinches minimum.

RoHS Compliance

This part is compliant with 2011/65/EU RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment) as amended by Directive 2015/863/EU.

This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A (C₁₅H₁₂Br₄O₂) Free
- PFOS Free
- SVHC Free



Contact Information

For the latest specifications, additional product information, worldwide sales and distribution locations:

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Tel: 1-844-890-8163

Email: customer.support@qorvo.com

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